

UltraVt[®] Depletion-Mode Power MOSFET

General Features

- ≻ ESD Improved Capability
- \triangleright Depletion Mode (Normally On)
- \triangleright Proprietary Advanced Planar Technology
- ≻ Proprietary Advanced Ultrahigh Vth Technology
- ≻ **RoHS** Compliant
- Halogen-free Available \triangleright

Applications

- Quick Charger ≻
- ≻ Current Source
- \triangleright Voltage Source
- Type-C/PD charger \triangleright

General Description

This novel depletion mode MOSFET, developed and manufactured by ARK proprietary UltraVt® technology. It has a high threshold voltage. By using the sub threshold characteristics, the depletion mode MOSFET can provide stably power to the load, and the voltage can be clamped to protect the load without Zener diode, and the circuit consumption is reduced.

Ordering Information

Part Number	Package	Marking	Remark
DMZ1315EL	SOT-23	1315L	Halogen Free
DMX1315EL	SOT-89	1315L	Halogen Free

Absolute Meximum Petings

Absolute Maximum Ratings			$T_A=25$ °C unless otherwise specified			
Symbol	Parameter	DMZ1315EL	DMX1315EL	Unit		
V _{DSX}	Drain-to-Source Voltage ^[1]	1.	V			
ID	Continuous Drain Current	0	0.1			
I _{DM}	Pulsed Drain Current ^[2]	0	0.4			
P _D	Power Dissipation	0.5 1.0		W		
V _{GS}	Gate-to-Source Voltage	±30		V		
V	Gate to Source ESD ^[3]	70	V			
V_{ESD}	Source to Gate ESD ^[3]	700		V		
T_L	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300		°C		
T_{J} and T_{STG}	Operating and Storage Temperature Range	-55 te				

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	DMZ1315EL	DMX1315EL	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	250	125	K/W

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BV_{DSX} VGS(off) IDSS,min 130V -13V to -20V 100mA





Electrical Characteristics OFF CL

OFF Characteristics $T_A = 25^{\circ}C$ unless otherwise spec						
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSX}	Drain-to-Source Breakdown Voltage	130			V	V _{GS} =-30V, I _D =1mA
I _{D(OFF)}	Drain-to-Source Leakage Current			10	μΑ	V_{DS} =130V, V_{GS} = -30V
I _{GSS}	Gate-to-Source Leakage Current			20	μA	V_{GS} =+30V, V_{DS} =0V
				-20		V_{GS} =-30V, V_{DS} =0V

ON Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
I _{DSS}	Saturated Drain-to-Source Current	100			mA	$V_{GS}=0V, V_{DS}=25V$
R _{DS(ON)}	Static Drain-to-Source On-Resistance		15	30	Ω	$V_{GS}=0V$, $I_D=50mA^{[4]}$
V _{GS(OFF)}	Gate-to-Source Cut-off Voltage	-13		-20	V	$V_{DS}=9V, I_D=8\mu A$

Source-Drain Diode Characteristics

Symbol	Parameter	Min	Тур.	Max.	Units	Test Conditions
V_{SD}	Diode Forward Voltage			1.2	V	I_{SD} =100mA, V_{GS} =-30V
NOTE:						

[1] T_J=+25 °C to +150 °C

[2] Repetitive rating, pulse width limited by maximum junction temperature.

[3] The test is based on JEDEC EIA/JESD22-A114 (HBM).

[4] Pulse width \leq 380 µs; duty cycle \leq 2%.

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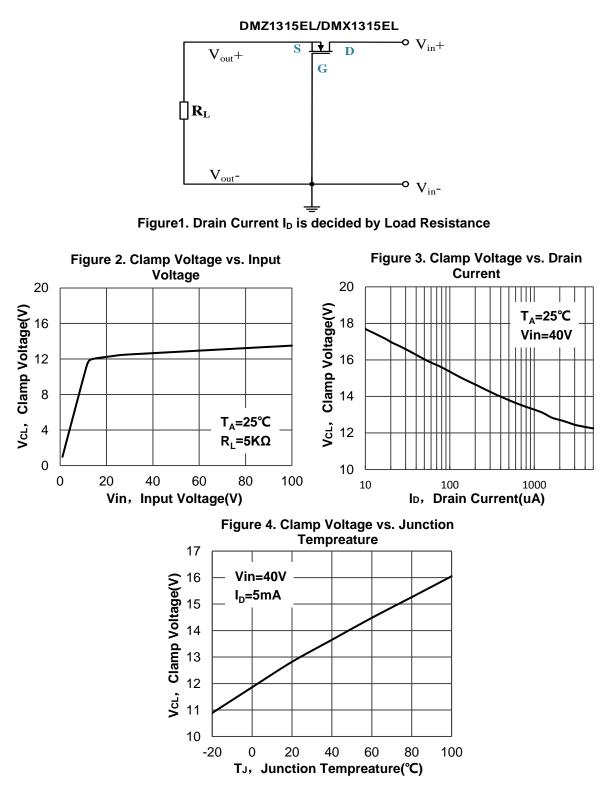
 $T_A = 25 \,^{\circ}C$ unless otherwise specified

 $T_A\!\!=\!\!25\,^\circ\!\mathrm{C}$ unless otherwise specified



Typical and highlight Characteristics

DMZ1315EL/DMX1315EL is an UltraVt[®] depletion mode MOS device. A stable output voltage source or current source is implemented by using the sub-threshold characteristics of the device. Its basic application is shown as Figure 1:



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Typical Application

In the QC2.0/3.0 and Type-C/PD charger circuits, using DMZ1315EL/DMX1315EL as a high voltage linear regulators can make the PWM IC power supply circuit more simplified, as shown below:

In Figure 5, the transistor Q is used to provide power, and the zener diode Z is used to clamp voltage, the power supply circuit of IC is composed of several components.

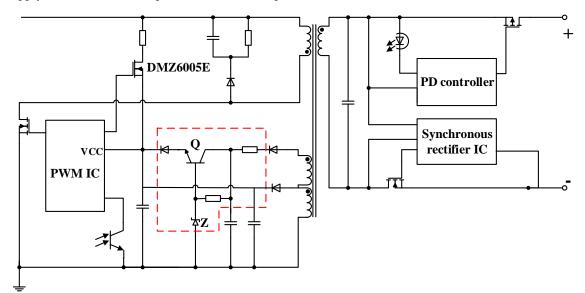
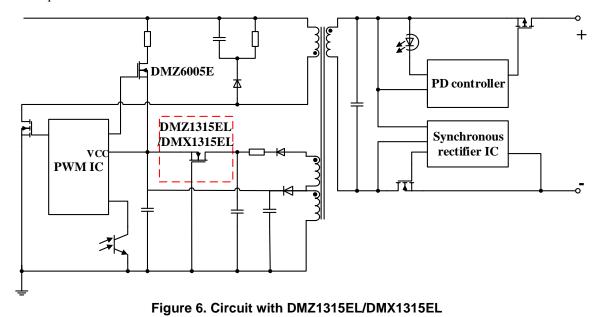


Figure 5. Normal Circuit with Transistor and Diode

In Figure 6, providing power and clamp voltage use only one device—DMZ1315EL/DMX1315EL, the circuit is simplified.



From the above function, we can see the depletion mode MOSFET operate in sub-threshold region, the Vout is always below or closed to the threshold voltage or Gate-to-Source Cut-off Voltage $V_{GS(OFF)}$, no matter how the input voltage Vin changes. Therefore, in addition to provide power for load like IC, the output voltage Vout can be clamped to the $V_{GS(OFF)}$, the IC is then protected from variable voltage or current. DMZ1315EL/DMX1315EL can support up to 130V input voltage. Vout and Vin have relations following the formulas:

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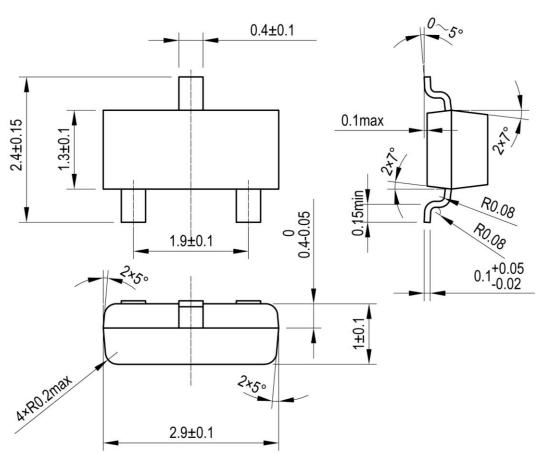


If $Vin < /V_{GS(OFF)}$ /, then $Vout \approx Vin$

If $Vin \ge /V_{GS(OFF)} /$, then $Vout \le V_{GS(OFF)}$

The Ultrahigh Vth Depletion Mode Power MOSFET--DMZ1315EL/DMX1315EL, was developed by ARK Microelectronics proprietary and patent technology. The threshold voltage $V_{GS(OFF)}$ of DMZ1315EL/DMX1315EL is between -13V and -20V, can provide sufficient voltage for load such like a PWM IC in the primary side of a Flyback converter.





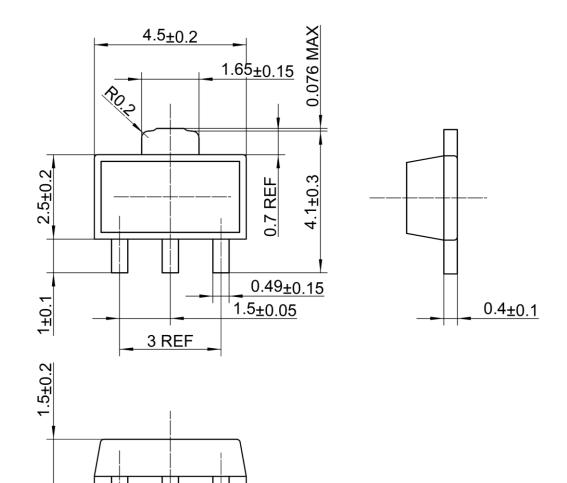
SOT-23

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SOT-89



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 - c. whose failure to perform when properly used in accordance with instructions for used provided in the labeling, can be reasonably expected to result in significant injury to the user.
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